



General Description

The AO4613 uses advanced trench technology MOSFETs to provide excellent $R_{DS(ON)}$ and low gate charge. The complementary MOSFETs may be used to form a level shifted high side switch, and for a host of other applications.

Product Summary

N-Channel

V_{DS} (V) = 30V
 $I_D = 7.2A$ ($V_{GS}=10V$)
 $R_{DS(ON)} < 24m\Omega$ ($V_{GS}=10V$)
 $< 40m\Omega$ ($V_{GS}=4.5V$)

P-Channel

-30V
 $-6.1A$ ($V_{GS}=10V$)
 $R_{DS(ON)} < 37m\Omega$ ($V_{GS} = -10V$)
 $< 60m\Omega$ ($V_{GS} = -4.5V$)

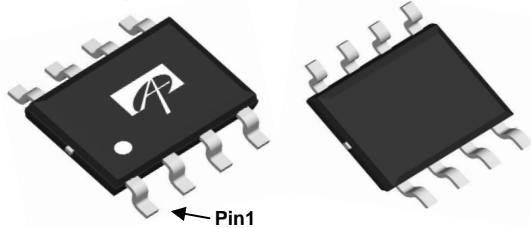
ESD Protected
 100% UIS Tested
 100% Rg Tested



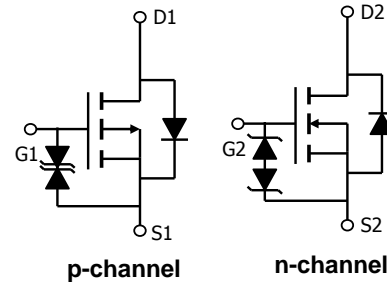
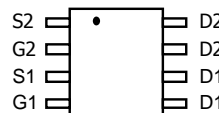
SOIC-8

Top View

Bottom View



Top View



Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

| Parameter | Symbol | Max n-channel | Max p-channel | Units |
|--|----------------|------------------|---------------|------------|
| Drain-Source Voltage | V_{DS} | 30 | -30 | V |
| Gate-Source Voltage | V_{GS} | ± 20 | ± 20 | V |
| Continuous Drain Current ^A | I_D | $T_A=25^\circ C$ | 7.2 | -6.1 |
| | | $T_A=70^\circ C$ | 6.1 | -5.1 |
| Pulsed Drain Current ^B | I_{DM} | 30 | -30 | A |
| Power Dissipation | P_D | $T_A=25^\circ C$ | 2 | 2 |
| | | $T_A=70^\circ C$ | 1.44 | 1.44 |
| Avalanche Current ^B | I_{AR} | 15 | 20 | A |
| Repetitive avalanche energy 0.1mH ^B | E_{AR} | 11 | 20 | mJ |
| Junction and Storage Temperature Range | T_J, T_{STG} | -55 to 150 | -55 to 150 | $^\circ C$ |

Thermal Characteristics: n-channel and p-channel

| Parameter | Symbol | Typ | Max | | Units | |
|--|-----------------|--------------|------|------|--------------|--------------|
| | | | n-ch | p-ch | | |
| Maximum Junction-to-Ambient ^A | $R_{\theta JA}$ | $t \leq 10s$ | 55 | 62.5 | $^\circ C/W$ | |
| Maximum Junction-to-Ambient ^A | | | 92 | 110 | $^\circ C/W$ | |
| Maximum Junction-to-Lead ^C | $R_{\theta JL}$ | Steady-State | n-ch | 37 | 50 | $^\circ C/W$ |
| Maximum Junction-to-Ambient ^A | | | p-ch | 48 | 62.5 | $^\circ C/W$ |
| Maximum Junction-to-Ambient ^A | $R_{\theta JA}$ | Steady-State | p-ch | 84 | 110 | $^\circ C/W$ |
| Maximum Junction-to-Lead ^C | | | p-ch | 37 | 50 | $^\circ C/W$ |

N-Channel Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|-----------------------------|---------------------------------------|--|-----|----------|----------|------------------|
| STATIC PARAMETERS | | | | | | |
| BV_{DSS} | Drain-Source Breakdown Voltage | $I_D=250\mu\text{A}$, $V_{GS}=0\text{V}$ | 30 | | | V |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS}=24\text{V}$, $V_{GS}=0\text{V}$ $T_J=55^\circ\text{C}$ | | | 1 5 | μA |
| I_{GSS} | Gate-Body leakage current | $V_{DS}=0\text{V}$, $V_{GS}=\pm 12\text{V}$ | | | 10 | μA |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS}=V_{GS}$, $I_D=250\mu\text{A}$ | 1 | 2 | 3 | V |
| $I_{D(ON)}$ | On state drain current | $V_{GS}=10\text{V}$, $V_{DS}=5\text{V}$ | 20 | | | A |
| $R_{DS(ON)}$ | Static Drain-Source On-Resistance | $V_{GS}=10\text{V}$, $I_D=7.2\text{A}$ $T_J=125^\circ\text{C}$ | | 20 29 | 24 35 | $\text{m}\Omega$ |
| | | $V_{GS}=4.5\text{V}$, $I_D=4\text{A}$ | | 30 | 40 | $\text{m}\Omega$ |
| g_{FS} | Forward Transconductance | $V_{DS}=5\text{V}$, $I_D=7.2\text{A}$ | 10 | 18 | | S |
| V_{SD} | Diode Forward Voltage | $I_S=1\text{A}$ | | 0.77 | 1 | V |
| I_S | Maximum Body-Diode Continuous Current | | | | 3 | A |
| DYNAMIC PARAMETERS | | | | | | |
| C_{iss} | Input Capacitance | $V_{GS}=0\text{V}$, $V_{DS}=15\text{V}$, $f=1\text{MHz}$ | | 522 | 630 | pF |
| C_{oss} | Output Capacitance | | | 110 | | pF |
| C_{rss} | Reverse Transfer Capacitance | | | 75 | | pF |
| R_g | Gate resistance | $V_{GS}=0\text{V}$, $V_{DS}=0\text{V}$, $f=1\text{MHz}$ | | 2.1 | 3 | Ω |
| SWITCHING PARAMETERS | | | | | | |
| $Q_g(10\text{V})$ | Total Gate Charge | $V_{GS}=10\text{V}$, $V_{DS}=15\text{V}$, $I_D=7.2\text{A}$ | | 11 | 15 | nC |
| $Q_g(4.5\text{V})$ | Total Gate Charge | | | 5.3 | 7 | nC |
| Q_{gs} | Gate Source Charge | | | 1.9 | | nC |
| Q_{gd} | Gate Drain Charge | | | 4 | | nC |
| $t_{D(on)}$ | Turn-On DelayTime | $V_{GS}=10\text{V}$, $V_{DS}=15\text{V}$, $R_L=2.1\Omega$, $R_{GEN}=3\Omega$ | | 4.7 | 7 | ns |
| t_r | Turn-On Rise Time | | | 4.9 | 10 | ns |
| $t_{D(off)}$ | Turn-Off DelayTime | | | 16.2 | 22 | ns |
| t_f | Turn-Off Fall Time | | | 3.5 | 7 | ns |
| t_{rr} | Body Diode Reverse Recovery Time | $I_F=7.2\text{A}$, $di/dt=100\text{A}/\mu\text{s}$ | | 15.7 | 20 | ns |
| Q_{rr} | Body Diode Reverse Recovery Charge | $I_F=7.2\text{A}$, $di/dt=100\text{A}/\mu\text{s}$ | | 7.9 | 10 | nC |

A: The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The value in any given application depends on the user's specific board design. The current rating is based on the $t \leq 10\text{s}$ thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C: The $R_{\theta JA}$ is the sum of the thermal impedance from junction to lead $R_{\theta JL}$ and lead to ambient. $R_{\theta JL}$ and $R_{\theta JC}$ are equivalent terms referring to thermal resistance from junction to drain lead.

D: The static characteristics in Figures 1 to 6 are obtained using 80 μs pulses, duty cycle 0.5% max.

E: These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The SOA curve provides a single pulse rating.

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P-Channel Electrical Characteristics (T_J=25°C unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|-----------------------------|---------------------------------------|---|-----|----------|----------|-------|
| STATIC PARAMETERS | | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | I _D =-250μA, V _{GS} =0V | -30 | | | V |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} =-24V, V _{GS} =0V T _J =55°C | | | -1 -5 | μA |
| I _{GSS} | Gate-Body leakage current | V _{DS} =0V, V _{GS} =±12V | | | 10 | μA |
| V _{GS(th)} | Gate Threshold Voltage | V _{DS} =V _{GS} , I _D =-250μA | -1 | -1.7 | -3 | V |
| I _{D(ON)} | On state drain current | V _{GS} =-10V, V _{DS} =-5V | 30 | | | A |
| R _{DS(ON)} | Static Drain-Source On-Resistance | V _{GS} =-10V, I _D =-6.1A T _J =125°C | | 28 39 | 37 48 | mΩ |
| | | V _{GS} =-4.5V, I _D =-4A | | 45 | 60 | |
| g _{FS} | Forward Transconductance | V _{DS} =-5V, I _D =-6.1A | | 12.5 | | S |
| V _{SD} | Diode Forward Voltage | I _S =-1A, V _{GS} =0V | | -0.77 | -1 | V |
| I _S | Maximum Body-Diode Continuous Current | | | | 3 | A |
| DYNAMIC PARAMETERS | | | | | | |
| C _{ISS} | Input Capacitance | V _{GS} =0V, V _{DS} =-15V, f=1MHz | | 1040 | 1250 | pF |
| C _{OSS} | Output Capacitance | | | 179 | | pF |
| C _{rss} | Reverse Transfer Capacitance | | | 134 | | pF |
| R _g | Gate resistance | V _{GS} =0V, V _{DS} =0V, f=1MHz | | 5 | 10 | Ω |
| SWITCHING PARAMETERS | | | | | | |
| Q _{g(10V)} | Total Gate Charge (10V) | V _{GS} =-10V, V _{DS} =-15V, I _D =-6.1A | | 16.8 | 22 | nC |
| Q _{g(4.5V)} | Total Gate Charge (4.5V) | | | 8.7 | 12 | nC |
| Q _{gs} | Gate Source Charge | | | 3.4 | | nC |
| Q _{gd} | Gate Drain Charge | | | 5 | | nC |
| t _{D(on)} | Turn-On DelayTime | V _{GS} =-10V, V _{DS} =-15V, R _L =2.5Ω, R _{GEN} =3Ω | | 9 | 12 | ns |
| t _r | Turn-On Rise Time | | | 5.7 | 11 | ns |
| t _{D(off)} | Turn-Off DelayTime | | | 22.7 | 30 | ns |
| t _f | Turn-Off Fall Time | | | 10.2 | 20 | ns |
| t _{rr} | Body Diode Reverse Recovery Time | I _F =-6.1A, di/dt=100A/μs | | 21.7 | 27 | ns |
| Q _{rr} | Body Diode Reverse Recovery Charge | I _F =-6.1A, di/dt=100A/μs | | 13.6 | 18 | nC |

A: The value of R_{θJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t ≤ 10s thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C. The R_{θJA} is the sum of the thermal impedance from junction to lead R_{θJL} and lead to ambient. R_{θJL} and R_{θJC} are equivalent terms referring to thermal resistance from junction to drain lead.

D. The static characteristics in Figures 1 to 6,12,14 are obtained using 80 μs pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The SOA curve provides a single pulse rating.

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N-CH TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

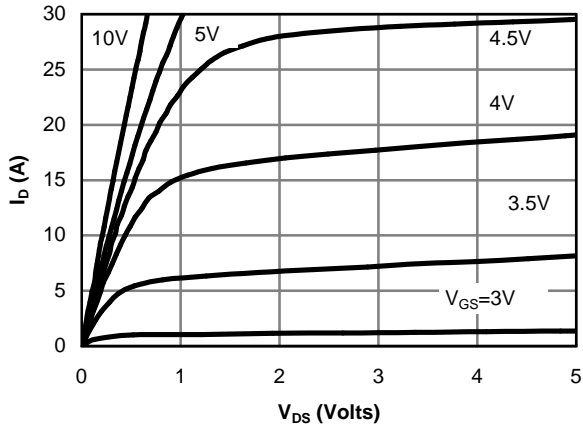


Fig 1: On-Region Characteristics

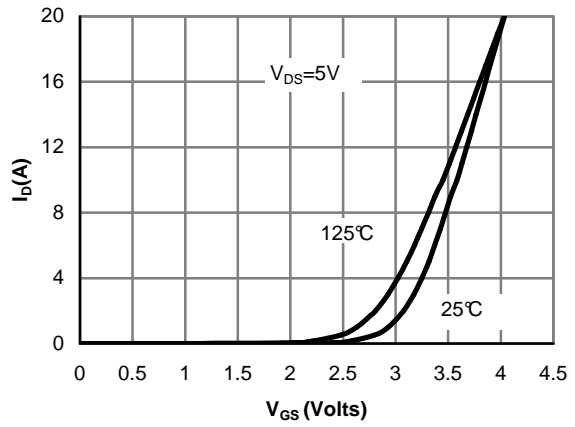


Figure 2: Transfer Characteristics

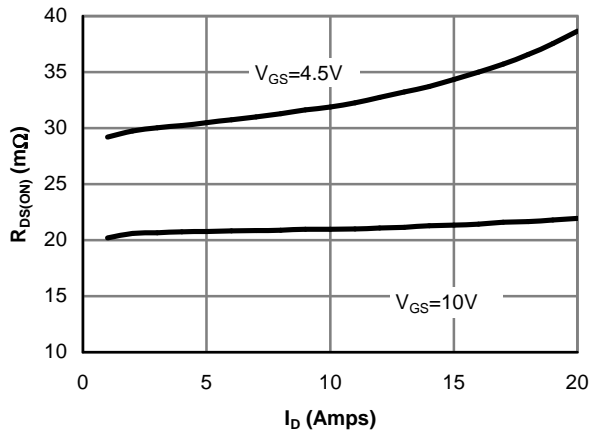


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

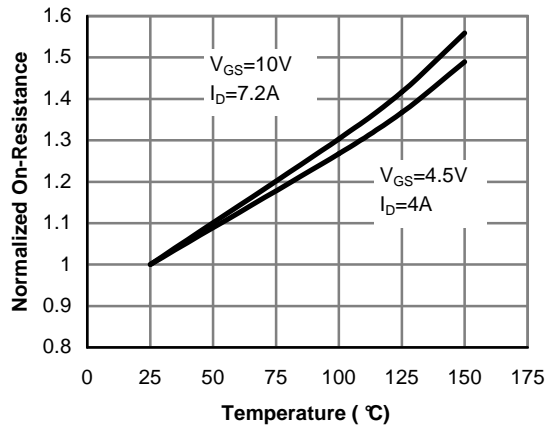


Figure 4: On-Resistance vs. Junction Temperature

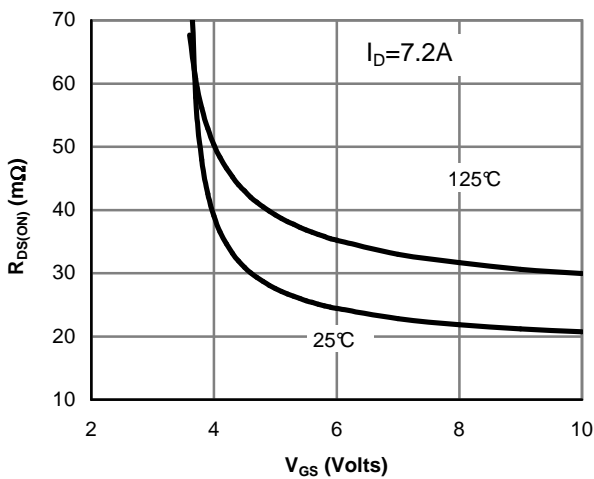


Figure 5: On-Resistance vs. Gate-Source Voltage

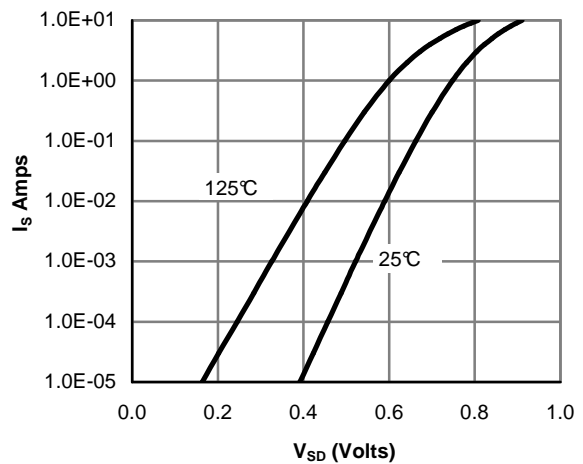


Figure 6: Body diode characteristics

N-CH TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

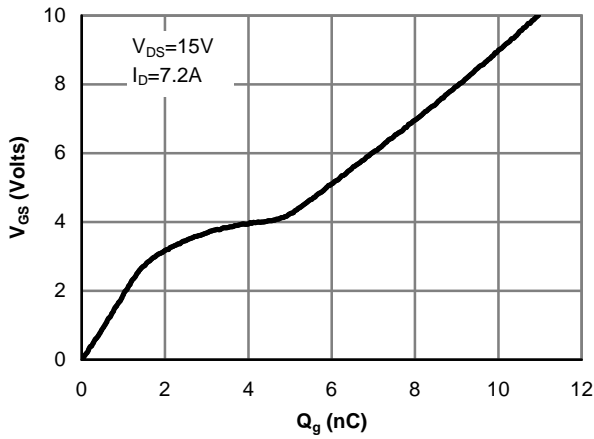


Figure 7: Gate-Charge characteristics

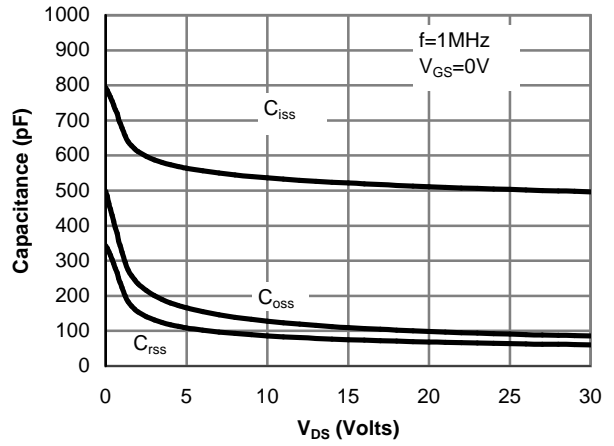


Figure 8: Capacitance Characteristics

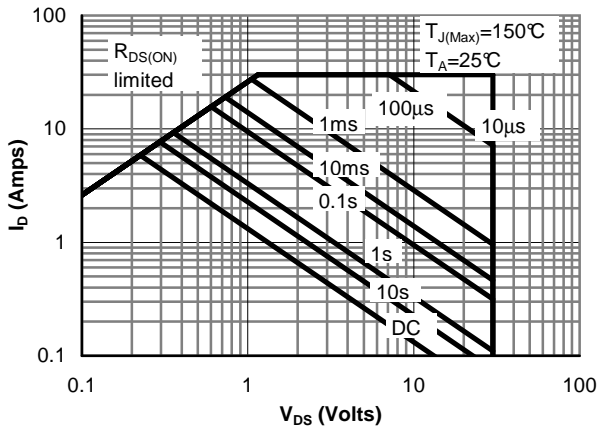


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

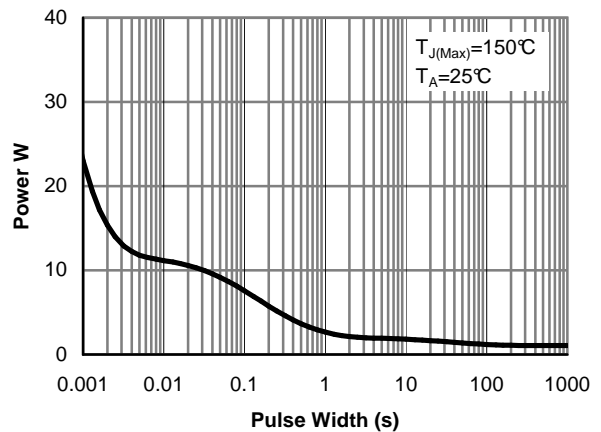


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

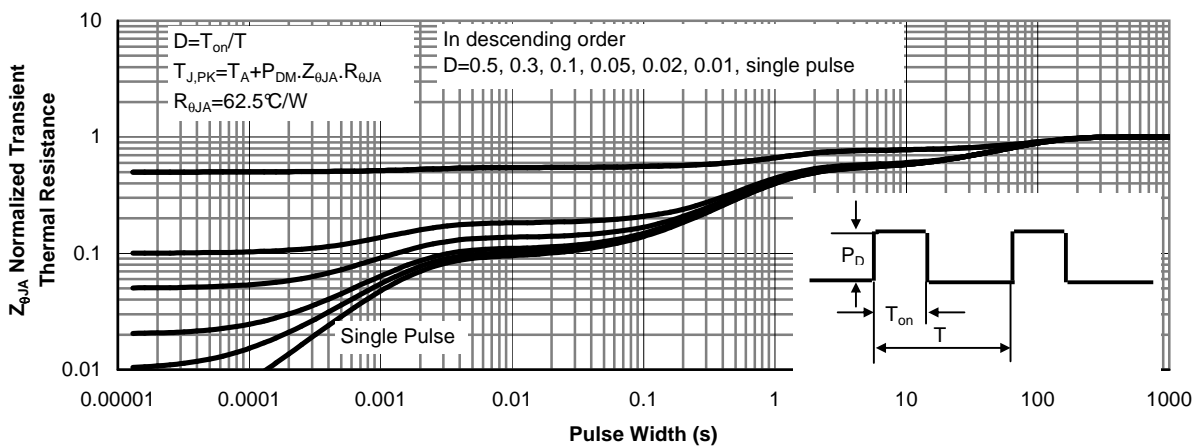


Figure 11: Normalized Maximum Transient Thermal Impedance

P-CH TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

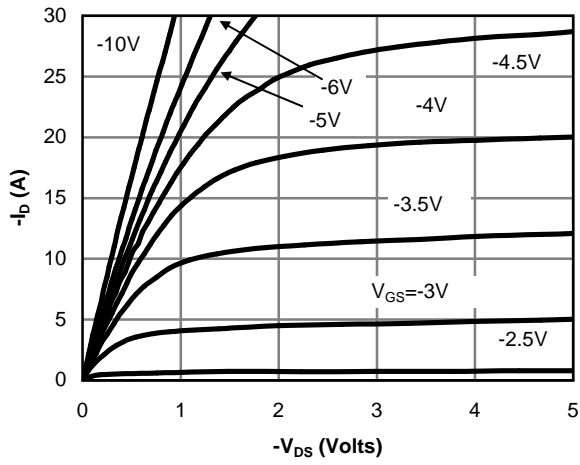


Fig 1: On-Region Characteristics

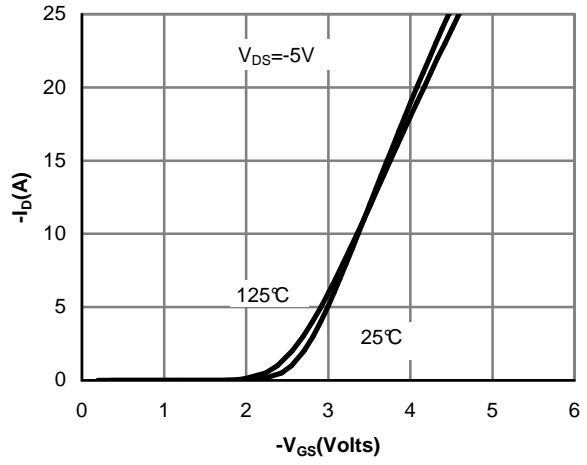


Figure 2: Transfer Characteristics

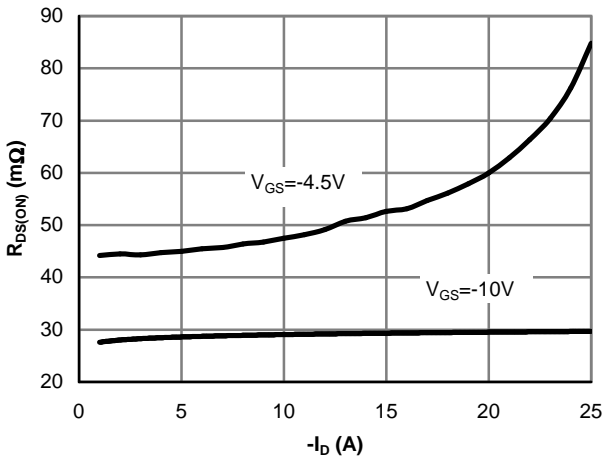


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

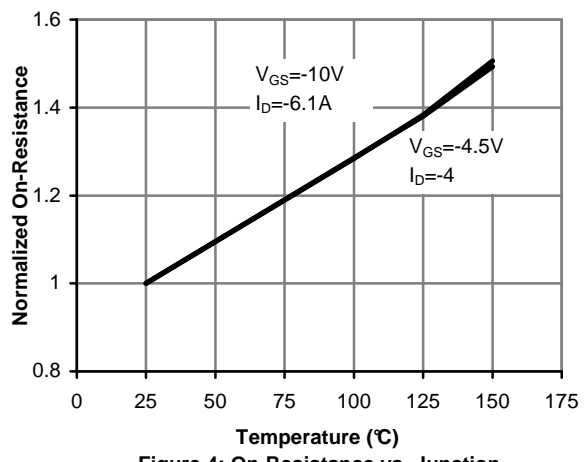


Figure 4: On-Resistance vs. Junction Temperature

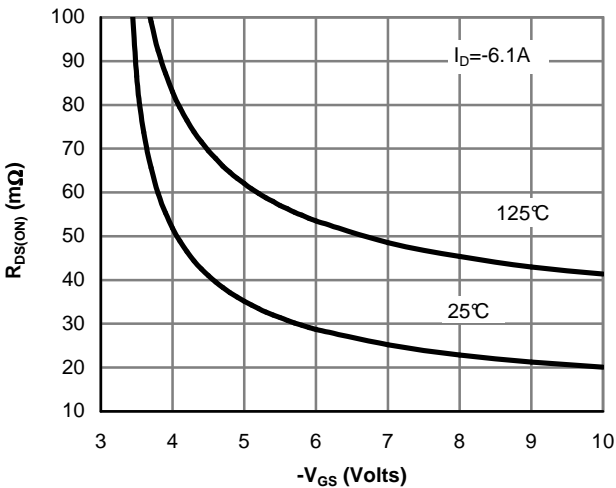


Figure 5: On-Resistance vs. Gate-Source Voltage

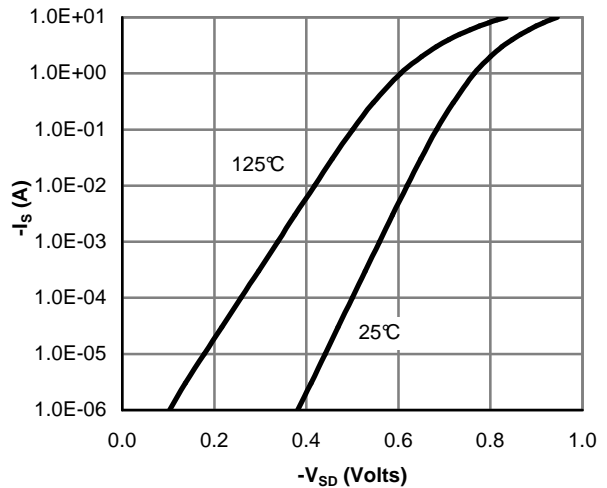


Figure 6: Body-Diode Characteristics

P-CH TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

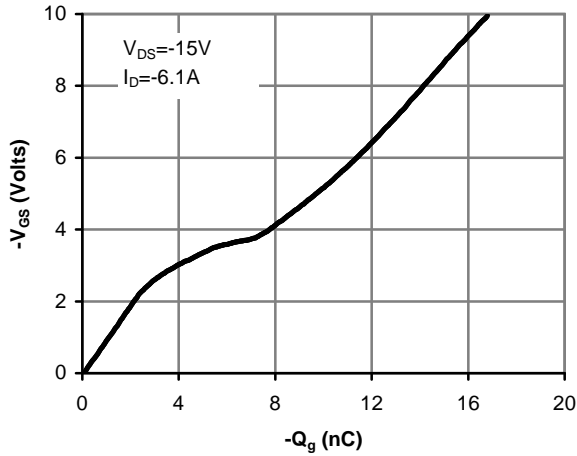


Figure 7: Gate-Charge Characteristics

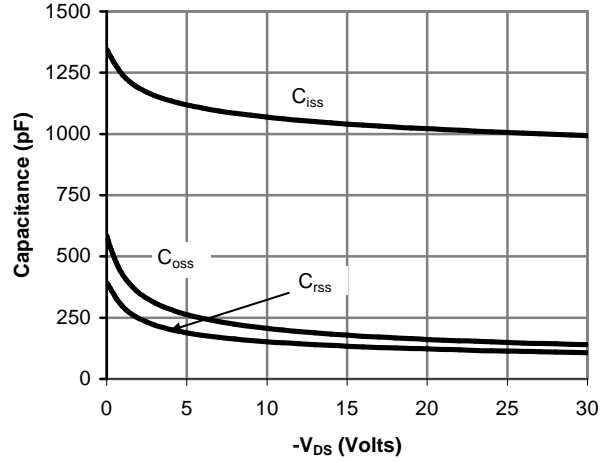


Figure 8: Capacitance Characteristics

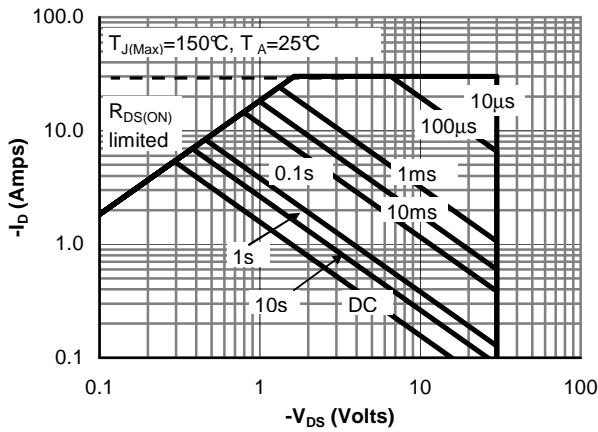


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

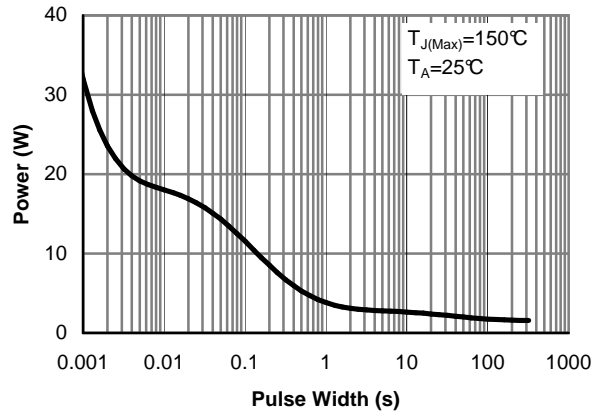


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

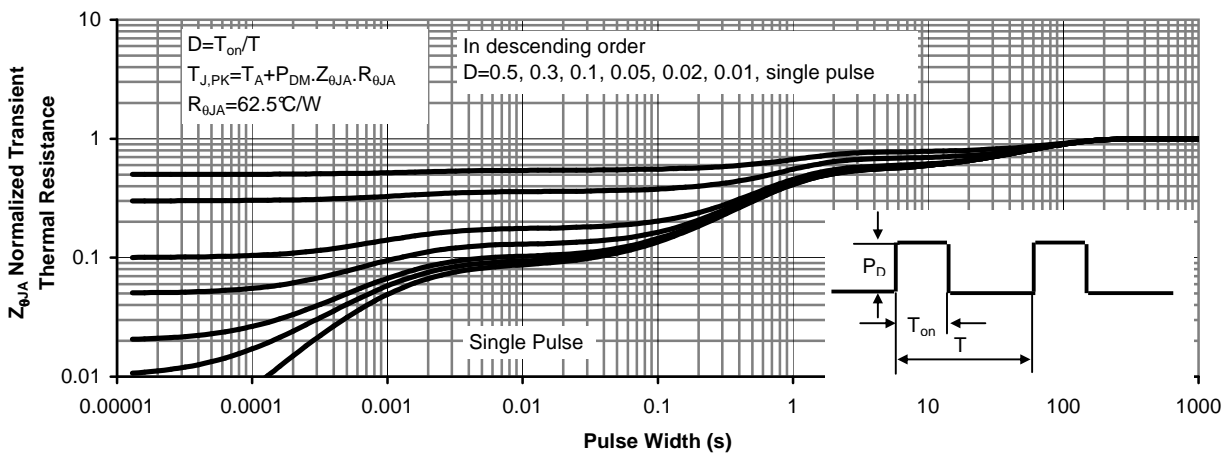


Figure 11: Normalized Maximum Transient Thermal Impedance